Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
09/679,896	SHIM, SOON SUN
Examiner	Art Unit
Gelek Topgyal	2621

SEARCHED			
Class	Subclass	Date	Examiner
386	83,46,95	12/26/2007	GТ
		_	
	1		

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
_				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Thai Tran: used same reference from inherited reissue case.	12/26/2007	GT
	,	